TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC74VHC374F,TC74VHC374FT,TC74VHC374FK

Octal D-Type Flip Flop with 3-State Output

The TC74VHC374 is an advanced high speed CMOS OCTAL FLIP-FLOP with 3-STATE OUTPUT fabricated with silicon gate C2MOS technology.

It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

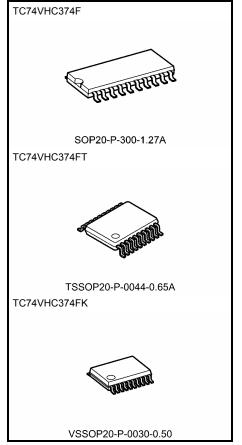
This 8-bit D-type flip-flop is controlled by a clock input (CK) and an output enable input (\overline{OE}).

When the $\overline{\mbox{OE}}$ input is high, the eight outputs are in a high impedance state.

An input protection circuit ensures that 0 to $5.5 \, V$ can be applied to the input pins without regard to the supply voltage. This device can be used to interface $5 \, V$ to $3 \, V$ systems and two supply systems such as battery back up. This circuit prevents device destruction due to mismatched supply and input voltages.

Features

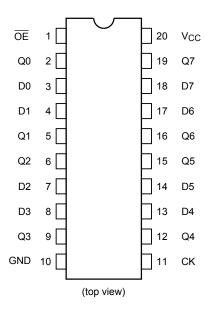
- High speed: $f_{max} = 185 \text{ MHz (typ.)}$ at $V_{CC} = 5 \text{ V}$
- Low power dissipation: $ICC = 4 \mu A \text{ (max)}$ at $Ta = 25^{\circ}C$
- High noise immunity: V_{NIH} = V_{NIL} = 28% V_{CC} (min)
- Power down protection is provided on all inputs.
- Balanced propagation delays: $t_{pLH} \approx t_{pHL}$
- Wide operating voltage range: $V_{CC \text{ (opr)}} = 2 \text{ to } 5.5 \text{ V}$
- Low noise: $V_{OLP} = 0.9 \text{ V (max)}$
- Pin and function compatible with 74ALS374



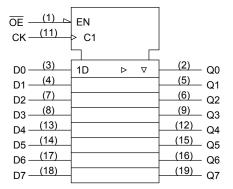
Weight

SOP20-P-300-1.27A : 0.22 g (typ.) TSSOP20-P-0044-0.65A : 0.08 g (typ.) VSSOP20-P-0030-0.50 : 0.03 g (typ.)

Pin Assignment



IEC Logic Symbol



Truth Table

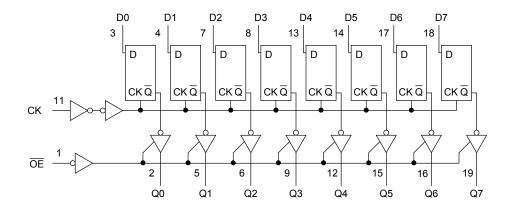
	Inputs	Output			
ŌE	CK	D	Output		
Н	Х	Х	Z		
L	\neg	Х	Qn		
L		L	L		
L		Н	Н		

X: Don't care

Z: High impedance

Q_n: No change

System Diagram





Absolute Maximum Ratings (Note)

Characteristics	Symbol	Rating	Unit
Supply voltage range	V _{CC}	−0.5 to 7.0	V
DC input voltage	V _{IN}	−0.5 to 7.0	V
DC output voltage	V _{OUT}	-0.5 to V _{CC} + 0.5	V
Input diode current	I _{IK}	-20	mA
Output diode current	lok	±20	mA
DC output current	lout	±25	mA
DC V _{CC} /ground current	Icc	±75	mA
Power dissipation	PD	180	mW
Storage temperature	T _{stg}	−65 to 150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Operating Ranges (Note)

Characteristics	Symbol	Rating	Unit	
Supply voltage	V _{CC}	2.0 to 5.5	V	
Input voltage	V _{IN}	0 to 5.5	V	
Output voltage	V _{OUT}	0 to V _{CC}	V	
Operating temperature	T _{opr}	-40 to 85	°C	
Input rise and fall time	dt/dv	0 to 100 (V _{CC} = 3.3 ± 0.3 V)	ns/V	
input rise and rail unle	uvuv	0 to 20 (V _{CC} = 5 ± 0.5 V)		

Note: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either V_{CC} or GND.



Electrical Characteristics

DC Characteristics

Characteristics	Symbol	Test Condition		Ta = 25°C			Ta = −40 to 85°C		Unit		
<i>Symbol</i>		V		V _{CC} (V)	Min	Тур.	Max	Min	Max		
High-level input		-		2.0	1.50	_	_	1.50			
voltage	V _{IH}			3.0 to 5.5	V _{CC} × 0.7	_	_	V _{CC} × 0.7	_	V	
Low-level input				2.0	_	_	0.50	_	0.50		
voltage	V _{IL}	_		3.0 to 5.5	_	_	V _{CC} × 0.3	_	V _{CC} × 0.3	V	
				2.0	1.9	2.0	_	1.9	_		
			I _{OH} = -50 μA	3.0	2.9	3.0	_	2.9	_		
High-level output voltage	V _{OH}	VIN = V _{IH} or V _{IL}		4.5	4.4	4.5	_	4.4	-	V	
			I _{OH} = -4 mA	3.0	2.58	_	_	2.48	-		
			I _{OH} = -8 mA	4.5	3.94	-	_	3.80	1		
	V _{OL}	VIN = V _{IH} or V _{IL}		2.0	_	0.0	0.1	_	0.1		
			I _{OL} = 50 μA	3.0	_	0.0	0.1	_	0.1		
Low-level output voltage				4.5	_	0.0	0.1	_	0.1	V	
			I _{OL} = 4 mA	3.0	_	_	0.36	_	0.44		
			I _{OL} = 8 mA	4.5	_	_	0.36	_	0.44		
3-state output off-state current	I _{OZ}	V _{IN} = V _{IH} or V _{IL} V _{OUT} = V _{CC} or GND		5.5	_	_	±0.25	_	±2.50	μΑ	
Input leakage current	I _{IN}	V _{IN} = 5.5 V or GND		0 to 5.5	ĺ	-	±0.1	l	±1.0	μΑ	
Quiescent supply current	Icc	V _{IN} = V _{CC} or	r GND	5.5	_	_	4.0	_	40.0	μΑ	

Timing Requirements (input: $t_r = t_f = 3 \text{ ns}$)

Characteristics	Symbol	Test Condition	Test Condition			Ta = -40 to 85°C	Unit
			V _{CC} (V)	Тур.	Limit	Limit	
Minimum pulse width	t _{w (H)}		3.3 ± 0.3	_	5.0	5.5	no
(CK)	t _{w (L)}	_	5.0 ± 0.5	_	5.0	5.0	ns
Minimum set-up time	t _s	_	3.3 ± 0.3	_	4.5	4.5	no
			5.0 ± 0.5	_	3.0	3.0	ns
Minimum hold time	4.	_	3.3 ± 0.3	_	2.0	2.0	no
	t _h		5.0 ± 0.5	_	2.0	2.0	ns



AC Characteristics (input: $t_r = t_f = 3$ ns)

Characteristics	Symbol	Test Condition		Ta = 25°C			Ta = −40 to 85°C		Unit	
	Cymbol		V _{CC} (V)	C _L (pF)	Min	Тур.	Max	Min	Max	Orint
			3.3 ± 0.3	15	_	8.1	12.7	1.0	15.0	- ns
Propagation delay time	t _{pLH}		3.3 ± 0.3	50		10.6	16.2	1.0	18.5	
(CK-Q)	t_{pHL}	_	5.0 ± 0.5	15	1	5.4	8.1	1.0	9.5	113
			3.0 1 0.5	50	I	6.9	10.1	1.0	11.5	
			3.3 ± 0.3	15	1	7.1	11.0	1.0	13.0	
3-state output enable	t_{pZL}	R _L = 1 kΩ	3.3 ± 0.5	50	1	9.6	14.5	1.0	16.5	ns
time	^t pZH	N 1 K12	5.0 ± 0.5	15	1	5.1	7.6	1.0	9.0	- 113
				50	I	6.6	9.6	1.0	11.0	
3-state output disable	t_{pLZ}	R _L = 1 kΩ	3.3 ± 0.3	50	1	10.2	14.0	1.0	16.0	- ns
time	t _{pHZ}		5.0 ± 0.5	50	_	6.1	8.8	1.0	10.0	
	f _{max}	_	3.3 ± 0.3	15	80	130		70	_	- MHz
Maximum clock				50	55	85	I	50	_	
frequency			5.0 ± 0.5	15	130	185		110	_	
			3.0 1 0.5	50	85	120	I	75	_	
Output to output skew	t _{osLH}	(Note 1)	3.3 ± 0.3	50	1	_	1.5	1	1.5	ns
Output to output skew	t _{osHL}	(Note 1)	5.0 ± 0.5	50	_	_	1.0	_	1.0	115
Input capacitance	C _{IN}		_		1	4	10	_	10	pF
Output capacitance	Cout		_		1	6	1	_	_	pF
Power dissipation capacitance	C _{PD}			(Note 2)	_	32	_	_	_	pF

Note 1: Parameter guaranteed by design.

 $t_{OSLH} = |t_{DLHm} - t_{DLHn}|, t_{OSHL} = |t_{DHLm} - t_{DHLn}|$

Note 2: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

$$I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/8 (per F/F)$$

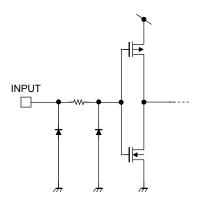
And the total $C_{\mbox{\scriptsize PD}}$ when n pcs. of latch operate can be gained by the following equation:



Noise Characteristics (input: $t_r = t_f = 3 \text{ ns}$)

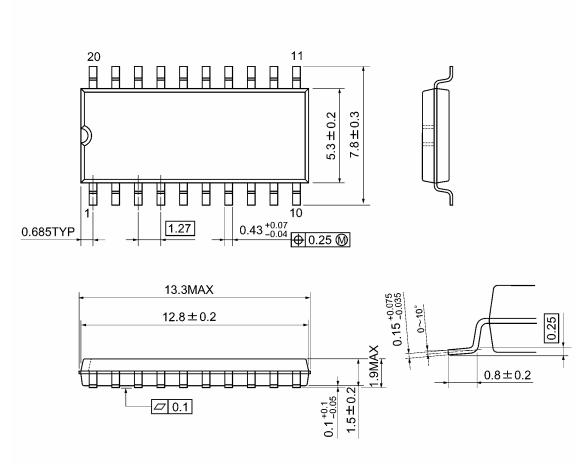
Characteristics	Symbol	Test Condition		Ta =	Unit	
Characteristics	Symbol		V _{CC} (V)	Тур.	Max	Offic
Quiet output maximum dynamic V _{OL}	V _{OLP}	C _L = 50 pF	5.0	0.5	8.0	V
Quiet output minimum dynamic V _{OL}	V _{OLV}	C _L = 50 pF	5.0	-0.5	-0.8	V
Minimum high level dynamic input voltage	V _{IHD}	C _L = 50 pF	5.0	_	3.5	V
Maximum low level dynamic input voltage	V_{ILD}	C _L = 50 pF	5.0	_	1.5	V

Input Equivalent Circuit



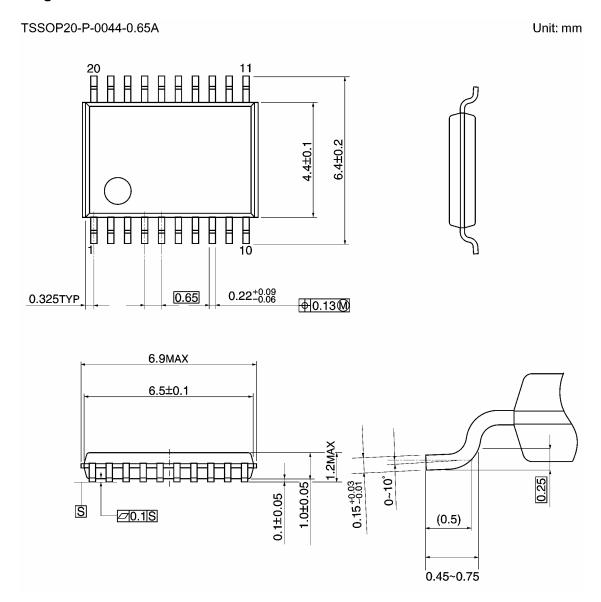
Package Dimensions

SOP20-P-300-1.27A Unit: mm



Weight: 0.22 g (typ.)

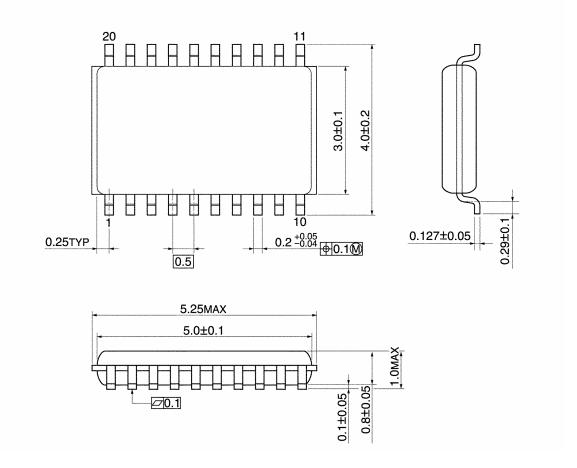
Package Dimensions



Weight: 0.08 g (typ.)

Package Dimensions

VSSOP20-P-0030-0.50 Unit: mm



Weight: 0.03 g (typ.)

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20070701-EN GENERAL

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